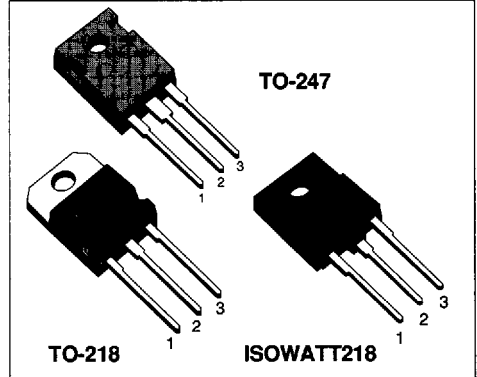


**N - CHANNEL ENHANCEMENT MODE
POWER MOS TRANSISTOR**

| TYPE | V _{DSS} | R _{DS(on)} | I _D |
|------------|------------------|---------------------|----------------|
| STH80N05 | 50 V | < 0.012 Ω | 80 A |
| STH80N05FI | 50 V | < 0.012 Ω | 52 A |
| STW80N05 | 50 V | < 0.012 Ω | 80 A |

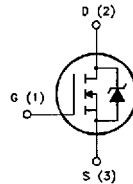
- TYPICAL R_{DS(on)} = 0.011 Ω
- AVALANCHE RUGGED TECHNOLOGY
- 100% AVALANCHE TESTED
- REPETITIVE AVALANCHE DATA AT 100°C
- LOW GATE CHARGE
- VERY HIGH CURRENT CAPABILITY
- 175°C OPERATING TEMPERATURE
- APPLICATION ORIENTED CHARACTERIZATION



APPLICATIONS

- HIGH CURRENT, HIGH SPEED SWITCHING
- SOLENOID AND RELAY DRIVERS
- REGULATORS
- DC-DC & DC-AC CONVERTERS
- MOTOR CONTROL
- AUTOMOTIVE ENVIRONMENT (INJECTION, ABS, AIR-BAG, Etc.)

INTERNAL SCHEMATIC DIAGRAM



ABSOLUTE MAXIMUM RATINGS

| Symbol | Parameter | Value | | Unit | |
|---------------------|---|--------------|------------|------|---|
| | | STW/STH80N05 | STH80N05FI | | |
| V _{DS} | Drain-source Voltage (V _{GS} = 0) | 50 | | V | |
| V _{DGR} | Drain- gate Voltage (R _{GS} = 20 kΩ) | 50 | | V | |
| V _{GS} | Gate-source Voltage | ± 20 | | V | |
| I _D | Drain Current (continuous) at T _c = 25 °C | 80 | 52 | A | |
| I _D | Drain Current (continuous) at T _c = 100 °C | 56 | 32 | A | |
| I _{DM} (*) | Drain Current (pulsed) | 320 | 320 | A | |
| P _{tot} | Total Dissipation at T _c = 25 °C | 200 | 70 | W | |
| | Derating Factor | 1.33 | 0.56 | W/°C | |
| V _{ISO} | Insulation Withstand Voltage (DC) | — | | 4000 | V |
| T _{stg} | Storage Temperature | -65 to 175 | | °C | |
| T _J | Max. Operating Junction Temperature | 175 | | °C | |

(*) Pulse width limited by safe operating area

THERMAL DATA

| | | | TO-218/TO-247 | ISOWATT218 | |
|-----------------------|--|-----|---------------|------------|------|
| R _{thj-case} | Thermal Resistance Junction-case | Max | 0.75 | 1.79 | °C/W |
| R _{thj-amb} | Thermal Resistance Junction-ambient | Max | 30 | | °C/W |
| R _{thc-sink} | Thermal Resistance Case-sink | Typ | 0.1 | | °C/W |
| T _l | Maximum Lead Temperature For Soldering Purpose | | 300 | | °C |

AVALANCHE CHARACTERISTICS

| Symbol | Parameter | Max Value | Unit |
|-----------------|--|-----------|------|
| I _{AR} | Avalanche Current, Repetitive or Not-Repetitive (pulse width limited by T _j max, δ < 1%) | 70 | A |
| E _{AS} | Single Pulse Avalanche Energy (starting T _j = 25 °C, I _D = I _{AR} , V _{DD} = 25 V) | 900 | mJ |
| E _{AR} | Repetitive Avalanche Energy (pulse width limited by T _j max, δ < 1%) | 200 | mJ |
| I _{AR} | Avalanche Current, Repetitive or Not-Repetitive (T _c = 100 °C, pulse width limited by T _j max, δ < 1%) | 45 | A |

ELECTRICAL CHARACTERISTICS (T_{case} = 25 °C unless otherwise specified)

OFF

| Symbol | Parameter | Test Conditions | Min. | Typ. | Max. | Unit |
|----------------------|---|--|------|------|-------------|----------|
| V _{(BR)DSS} | Drain-source Breakdown Voltage | I _D = 250 μA V _{GS} = 0 | 50 | | | V |
| I _{DSS} | Zero Gate Voltage Drain Current (V _{GS} = 0) | V _{DS} = Max Rating V _{DS} = Max Rating x 0.8 T _c = 125 °C | | | 250 1000 | μA μA |
| I _{GSS} | Gate-body Leakage Current (V _{DS} = 0) | V _{GS} = ± 20 V | | | ± 100 | nA |

ON (*)

| Symbol | Parameter | Test Conditions | Min. | Typ. | Max. | Unit |
|---------------------|-----------------------------------|---|------|-------|----------------|--------|
| V _{GS(th)} | Gate Threshold Voltage | V _{DS} = V _{GS} I _D = 250 μA | 2 | 2.9 | 4 | V |
| R _{DS(on)} | Static Drain-source On Resistance | V _{GS} = 10V I _D = 40 A V _{GS} = 10V I _D = 40 A T _c = 100°C | | 0.011 | 0.012 0.024 | Ω Ω |
| I _{D(on)} | On State Drain Current | V _{DS} > I _{D(on)} x R _{DS(on)max} V _{GS} = 10 V | 80 | | | A |

DYNAMIC

| Symbol | Parameter | Test Conditions | Min. | Typ. | Max. | Unit |
|---------------------|------------------------------|---|------|------|------|------|
| g _{fs} (*) | Forward Transconductance | V _{DS} > I _{D(on)} x R _{DS(on)max} I _D = 40 A | 25 | 45 | | S |
| C _{iss} | Input Capacitance | V _{DS} = 25 V f = 1 MHz V _{GS} = 0 | | 4000 | 5200 | pF |
| C _{oss} | Output Capacitance | | | 1800 | 2300 | pF |
| C _{rss} | Reverse Transfer Capacitance | | | 500 | 650 | pF |

ELECTRICAL CHARACTERISTICS (continued)

SWITCHING ON

| Symbol | Parameter | Test Conditions | Min. | Typ. | Max. | Unit |
|-------------------------------|--|---|------|-----------------|-------------|----------------|
| $t_{d(on)}$ t_r | Turn-on Time Rise Time | $V_{DD} = 25\text{ V}$ $I_D = 40\text{ A}$ $R_G = 50\ \Omega$ $V_{GS} = 10\text{ V}$ (see test circuit, figure 3) | | 190 900 | 270 1300 | ns ns |
| $(di/dt)_{on}$ | Turn-on Current Slope | $V_{DD} = 40\text{ V}$ $I_D = 80\text{ A}$ $R_G = 50\ \Omega$ $V_{GS} = 10\text{ V}$ (see test circuit, figure 5) | | 150 | | A/ μ s |
| Q_g Q_{gs} Q_{gd} | Total Gate Charge Gate-Source Charge Gate-Drain Charge | $V_{DD} = 25\text{ V}$ $I_D = 40\text{ A}$ $V_{GS} = 10\text{ V}$ | | 130 27 48 | 180 | nC nC nC |

SWITCHING OFF

| Symbol | Parameter | Test Conditions | Min. | Typ. | Max. | Unit |
|----------------------------------|---|---|------|-------------------|-------------------|----------------|
| $t_r(V_{off})$ t_f t_c | Off-voltage Rise Time Fall Time Cross-over Time | $V_{DD} = 40\text{ V}$ $I_D = 80\text{ A}$ $R_G = 50\ \Omega$ $V_{GS} = 10\text{ V}$ (see test circuit, figure 5) | | 450 350 700 | 600 480 950 | ns ns ns |

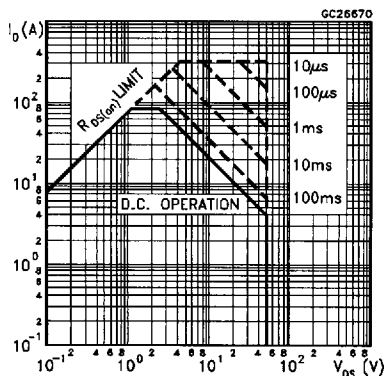
SOURCE DRAIN DIODE

| Symbol | Parameter | Test Conditions | Min. | Typ. | Max. | Unit |
|-----------------------------------|--|---|------|------------------|-----------|--------------------|
| I_{SD} $I_{SDM}(\bullet)$ | Source-drain Current Source-drain Current (pulsed) | | | | 80 320 | A A |
| $V_{SD}(\ast)$ | Forward On Voltage | $I_{SD} = 80\text{ A}$ $V_{GS} = 0$ | | | 1.6 | V |
| t_{rr} Q_{rr} I_{RRM} | Reverse Recovery Time Reverse Recovery Charge Reverse Recovery Current | $I_{SD} = 80\text{ A}$ $di/dt = 100\text{ A}/\mu\text{s}$ $V_{DD} = 35\text{ V}$ $T_j = 150\text{ }^\circ\text{C}$ (see test circuit, figure 5) | | 130 0.45 7 | | ns μ C A |

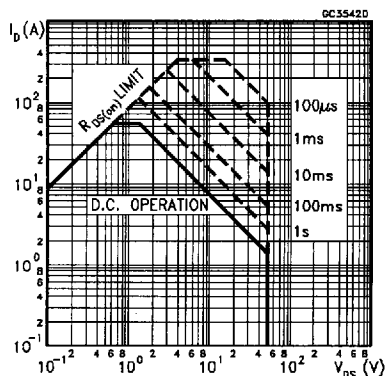
(*) Pulsed: Pulse duration = 300 μ s, duty cycle 1.5 %

(\bullet) Pulse width limited by safe operating area

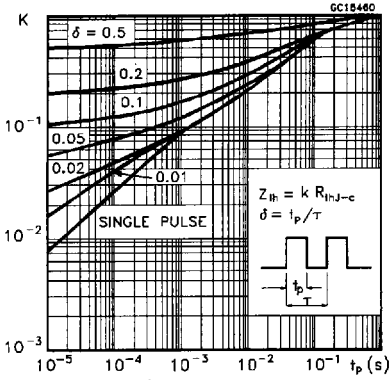
Safe Operating Areas For TO-218 and TO-247



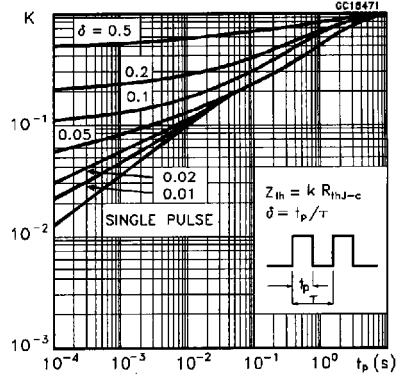
Safe Operating Areas For ISOWATT218



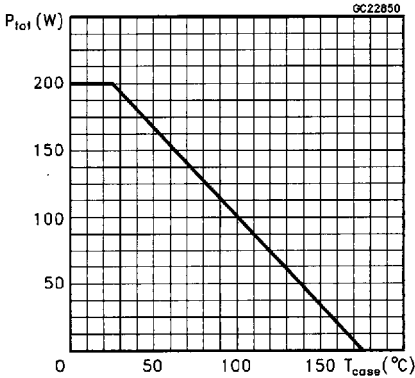
Thermal Impedance For TO-218 and TO-247



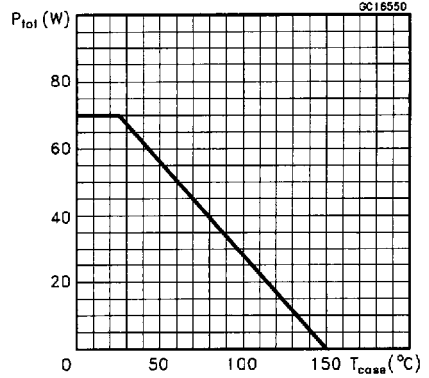
Thermal Impedance For ISOWATT218



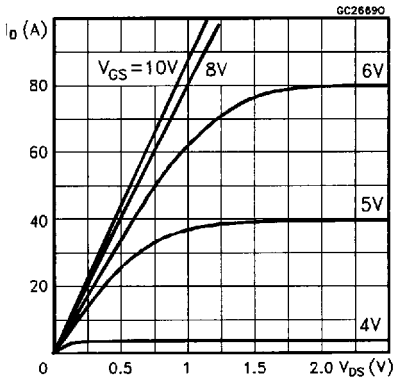
Derating Curve For TO-218 and TO-247



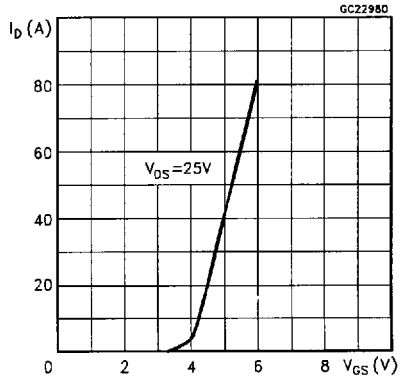
Derating Curve For ISOWATT218



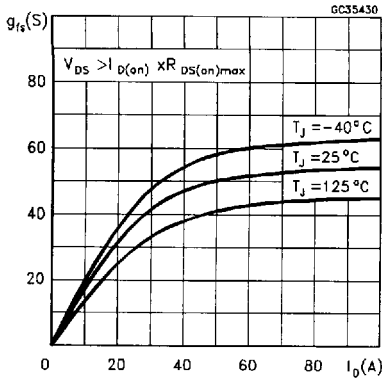
Output Characteristics



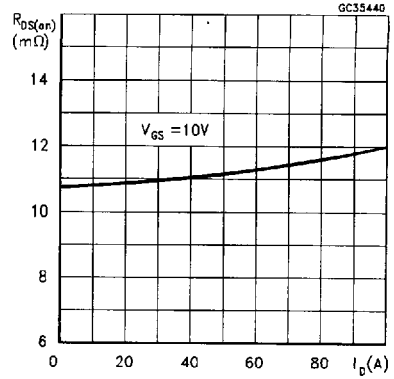
Transfer Characteristics



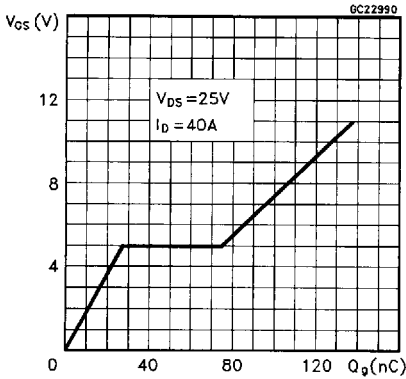
Transconductance



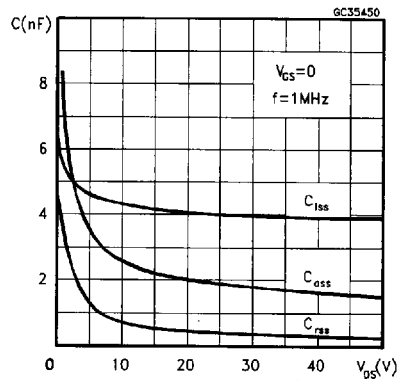
Static Drain-source On Resistance



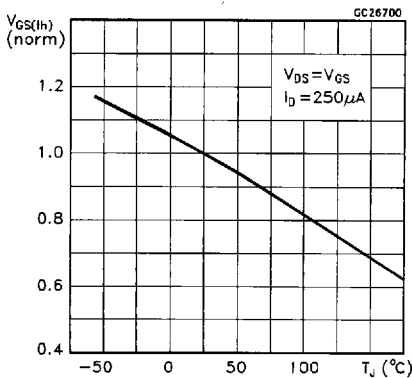
Gate Charge vs Gate-source Voltage



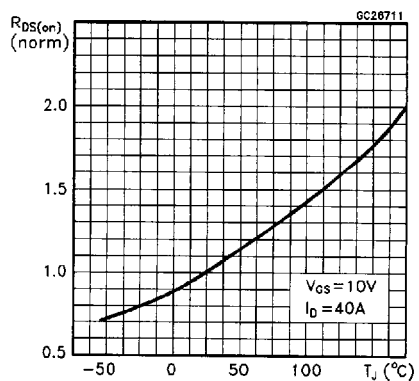
Capacitance Variations



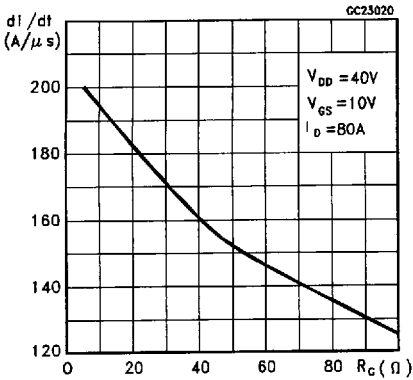
Normalized Gate Threshold Voltage vs Temperature



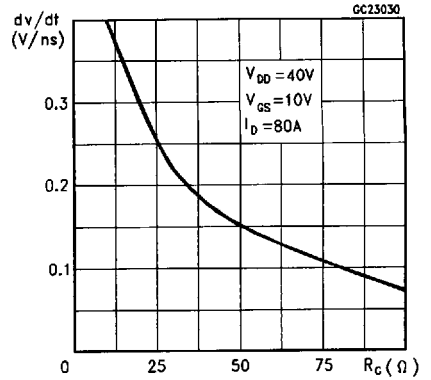
Normalized On Resistance vs Temperature



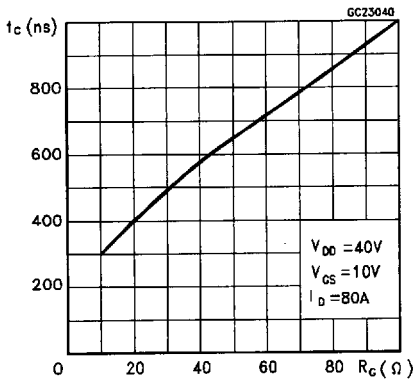
Turn-on Current Slope



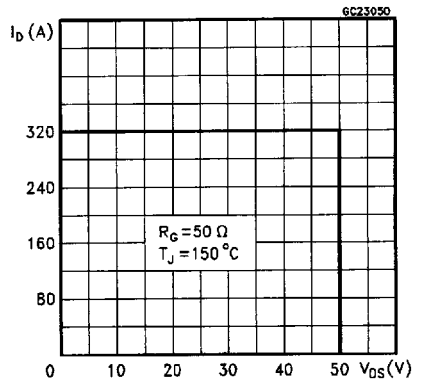
Turn-off Drain-source Voltage Slope



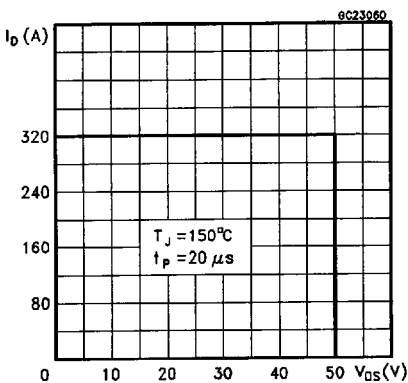
Cross-over Time



Switching Safe Operating Area



Accidental Overload Area



Source-drain Diode Forward Characteristics

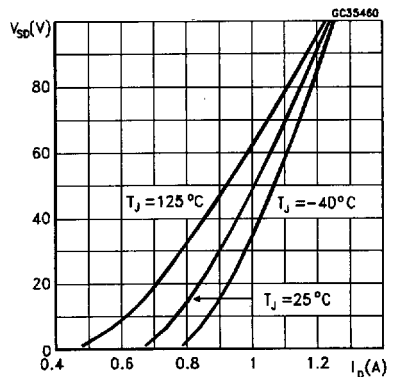


Fig. 1: Unclamped Inductive Load Test Circuits

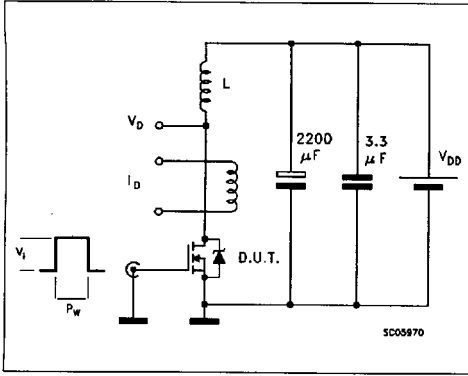


Fig. 2: Unclamped Inductive Waveforms

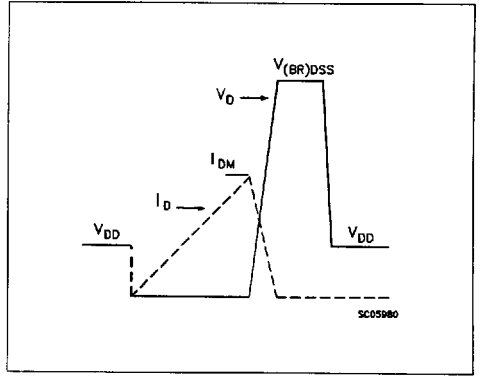


Fig. 3: Switching Times Test Circuits For Resistive Load

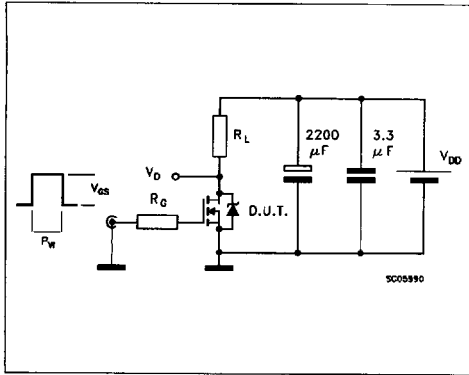


Fig. 4: Gate Charge Test Circuit

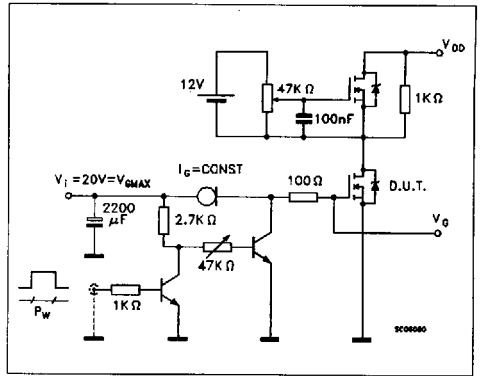


Fig. 5: Test Circuit For Inductive Load Switching And Diode Reverse Recovery Time

